Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/520,010	KAWAMURA ET AL.	
Examiner	Art Unit	
Thinh T. Nguyen	2818	

SEARCHED				
Class	Subclass	Date	Examiner	
257	414	5/26/2006	TTN	
257	40	5/26/2006	TTN	
257	72	5/26/2006	TTN	

INTERFERENCE SEARCHED			
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EAST	PUB	5/26/2006	TTN
	<u>.                                    </u>		

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